

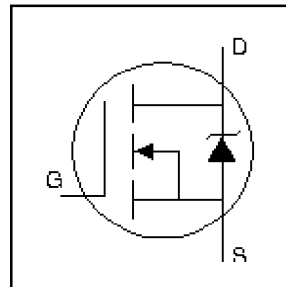
**HEXFET® Power MOSFET**

- Advanced Process Technology
- Isolated Package
- High Voltage Isolation = 2.5KVRMS ⑤
- Sink to Lead Creepage Dist. = 4.8mm
- Fully Avalanche Rated

**Description**

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design for which HEXFET Power MOSFETs are well known, provides the designer with an extremely efficient device for use in a wide variety of applications.

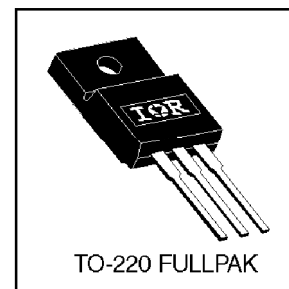
The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.



$$V_{DSS} = 100V$$

$$R_{DS(on)} = 0.11\Omega$$

$$I_D = 11A$$



**Absolute Maximum Ratings**

|                             | Parameter                                | Max.                  | Units |
|-----------------------------|------------------------------------------|-----------------------|-------|
| $I_D$ @ $T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS}$ @ 10V | 11                    | A     |
| $I_D$ @ $T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS}$ @ 10V | 7.8                   |       |
| $I_{DM}$                    | Pulsed Drain Current ①⑥                  | 60                    |       |
| $P_D$ @ $T_C = 25^\circ C$  | Power Dissipation                        | 33                    | W     |
|                             | Linear Derating Factor                   | 0.22                  | W/°C  |
| $V_{GS}$                    | Gate-to-Source Voltage                   | ±20                   | V     |
| $E_{AS}$                    | Single Pulse Avalanche Energy ②⑥         | 150                   | mJ    |
| $I_{AR}$                    | Avalanche Current①⑥                      | 9.0                   | A     |
| $E_{AR}$                    | Repetitive Avalanche Current①⑥           | 6.3                   | mJ    |
| $dv/dt$                     | Peak Diode Recovery $dv/dt$ ③⑥           | 5.2                   | V/ns  |
| $T_J$                       | Operating Junction and                   | -55 to + 175          | °C    |
| $T_{STG}$                   | Storage Temperature Range                |                       |       |
|                             | Soldering Temperature, for 10 seconds    | 300 (1.6mm from case) |       |
|                             | Mounting torque, 6-32 or M3 screw.       | 10 lbf•in (1.1N•m)    |       |

**Thermal Resistance**

|                 | Parameter           | Min. | Typ. | Max. | Units |
|-----------------|---------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case    | —    | —    | 4.5  | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient | —    | —    | 65   |       |

# IRF530N



## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ. | Max. | Units    | Conditions                                           |
|---------------------------------|--------------------------------------|------|------|------|----------|------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 100  | —    | —    | V        | $V_{GS} = 0V, I_D = 250\mu A$                        |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.12 | —    | V/°C     | Reference to $25^\circ\text{C}$ , $I_D = 1mA$ ⑥      |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.11 | $\Omega$ | $V_{GS} = 10V, I_D = 6.6A$ ④                         |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —    | 4.0  | V        | $V_{DS} = V_{GS}, I_D = 250\mu A$                    |
| $g_{fs}$                        | Forward Transconductance             | 6.4  | —    | —    | S        | $V_{DS} = 50V, I_D = 9.0A$ ⑥                         |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25   | $\mu A$  | $V_{DS} = 100V, V_{GS} = 0V$                         |
|                                 |                                      | —    | —    | 250  |          | $V_{DS} = 80V, V_{GS} = 0V, T_J = 150^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA       | $V_{GS} = 20V$                                       |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |          | $V_{GS} = -20V$                                      |
| $Q_g$                           | Total Gate Charge                    | —    | —    | 44   | nC       | $I_D = 9.0A$                                         |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —    | 6.2  |          | $V_{DS} = 80V$                                       |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —    | 21   |          | $V_{GS} = 10V$ , See Fig. 6 and 13 ④⑥                |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 6.4  | —    | ns       | $V_{DD} = 50V$                                       |
| $t_r$                           | Rise Time                            | —    | 27   | —    |          | $I_D = 9.0A$                                         |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 37   | —    |          | $R_G = 12\Omega$                                     |
| $t_f$                           | Fall Time                            | —    | 25   | —    |          | $R_D = 5.5\Omega$ , See Fig. 10 ④⑥                   |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5  | —    | nH       | Between lead,<br>6mm (0.25in.)                       |
| $L_S$                           | Internal Source Inductance           | —    | 7.5  | —    |          | from package<br>and center of die contact            |
| $C_{iss}$                       | Input Capacitance                    | —    | 640  | —    | pF       | $V_{GS} = 0V$                                        |
| $C_{oss}$                       | Output Capacitance                   | —    | 160  | —    |          | $V_{DS} = 25V$                                       |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 88   | —    |          | $f = 1.0MHz$ , See Fig. 5⑥                           |
| $C$                             | Drain to Sink Capacitance            | —    | 12   | —    |          | $f = 1.0MHz$                                         |



## Source-Drain Ratings and Characteristics

|          | Parameter                                 | Min. | Typ. | Max. | Units | Conditions                                                              |
|----------|-------------------------------------------|------|------|------|-------|-------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —    | —    | 11   | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode) ①⑥  | —    | —    | 60   |       |                                                                         |
| $V_{SD}$ | Diode Forward Voltage                     | —    | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 6.6A, V_{GS} = 0V$ ④                     |
| $t_{rr}$ | Reverse Recovery Time                     | —    | 130  | 190  | ns    | $T_J = 25^\circ\text{C}, I_F = 9.0A$                                    |
| $Q_{rr}$ | Reverse Recovery Charge                   | —    | 650  | 970  | nC    | $di/dt = 100A/\mu s$ ④⑥                                                 |

### Notes:

① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )

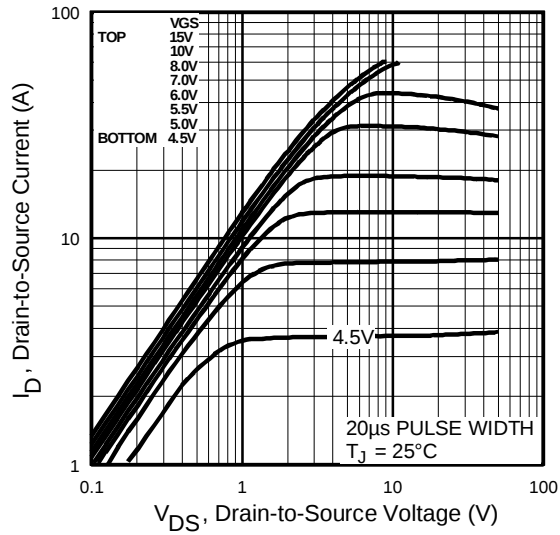
②  $V_{DD} = 15V$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 3.1mH$   
 $R_G = 25\Omega$ ,  $I_{AS} = 9.0A$ . (See Figure 12)

③  $I_{SD} \leq 9.0A$ ,  $di/dt \leq 520A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  
 $T_J \leq 175^\circ\text{C}$

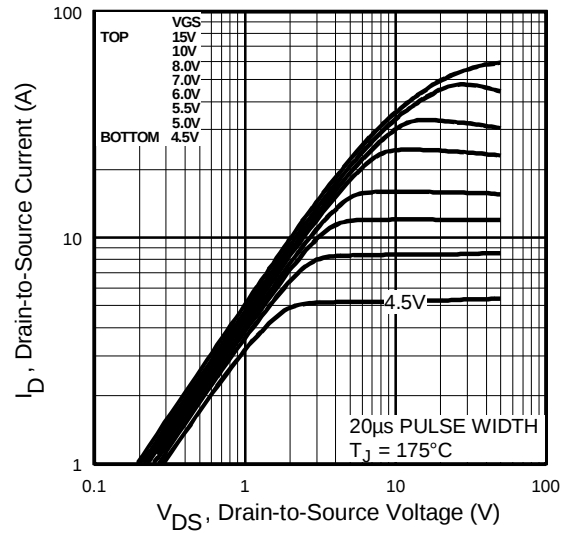
④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .

⑤  $t = 60s$ ,  $f = 60Hz$

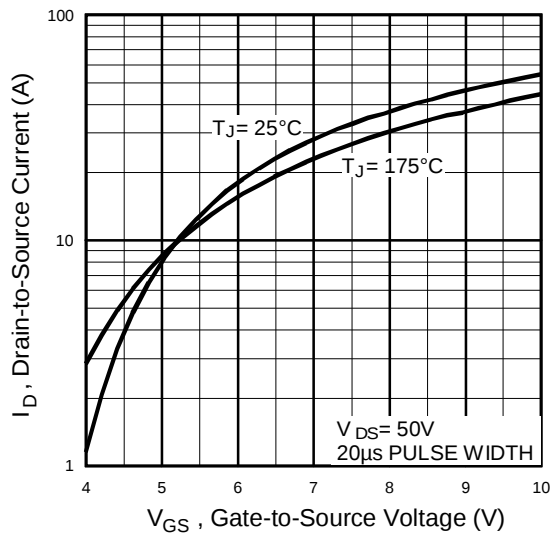
⑥ Uses IRF530N data and test conditions



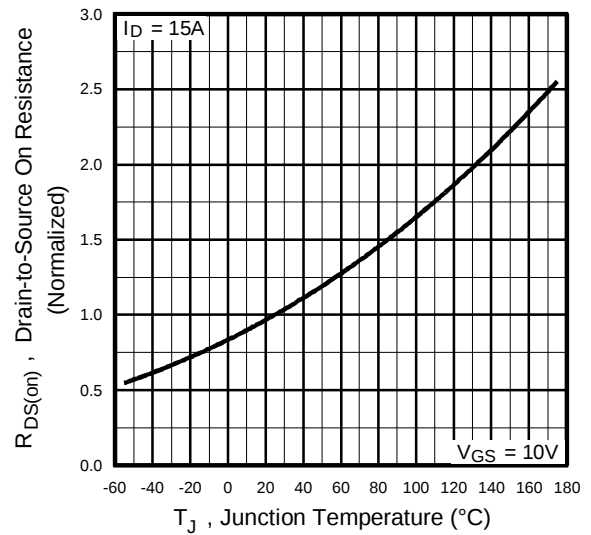
**Fig 1.** Typical Output Characteristics,  
 $T_J = 25^\circ\text{C}$



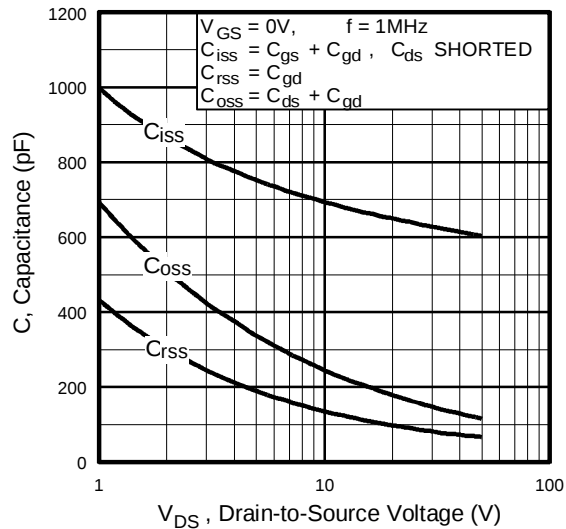
**Fig 2.** Typical Output Characteristics,  
 $T_J = 175^\circ\text{C}$



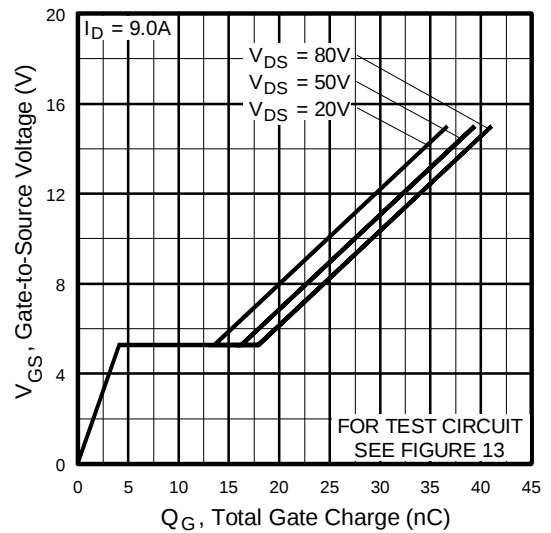
**Fig 3.** Typical Transfer Characteristics



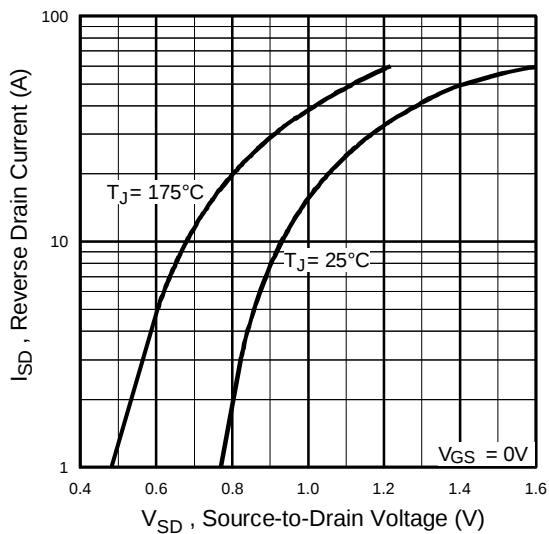
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



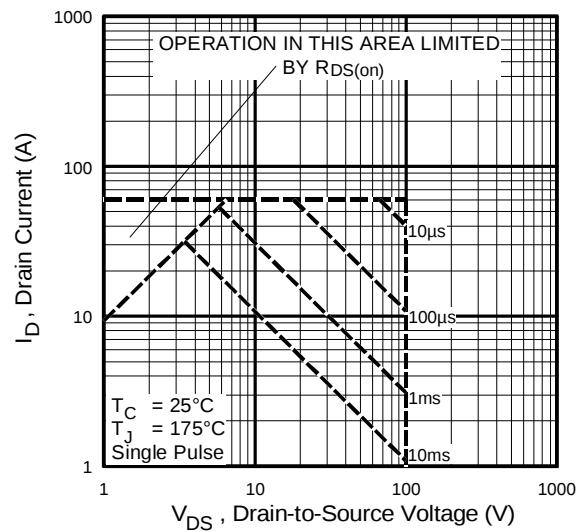
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



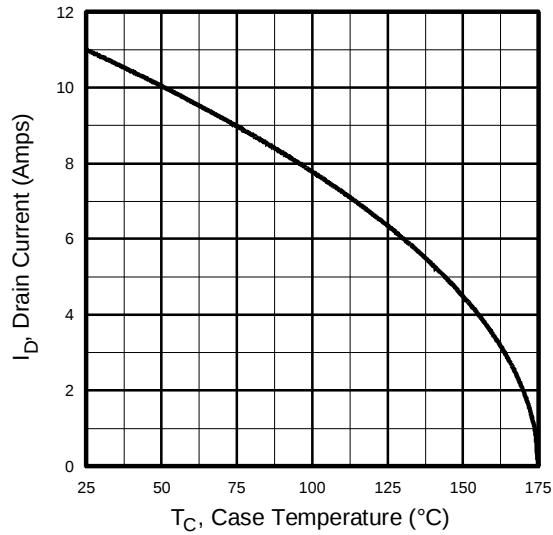
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



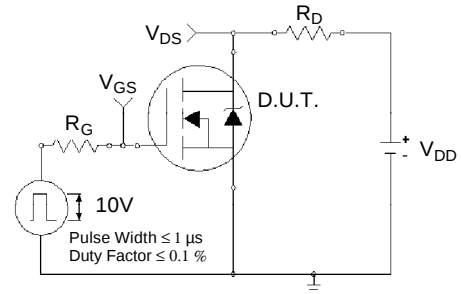
**Fig 7.** Typical Source-Drain Diode Forward Voltage



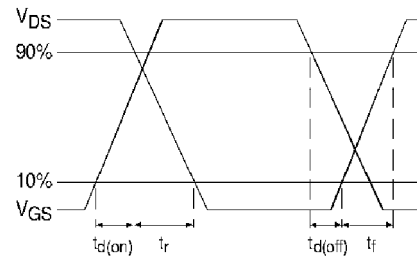
**Fig 8.** Maximum Safe Operating Area



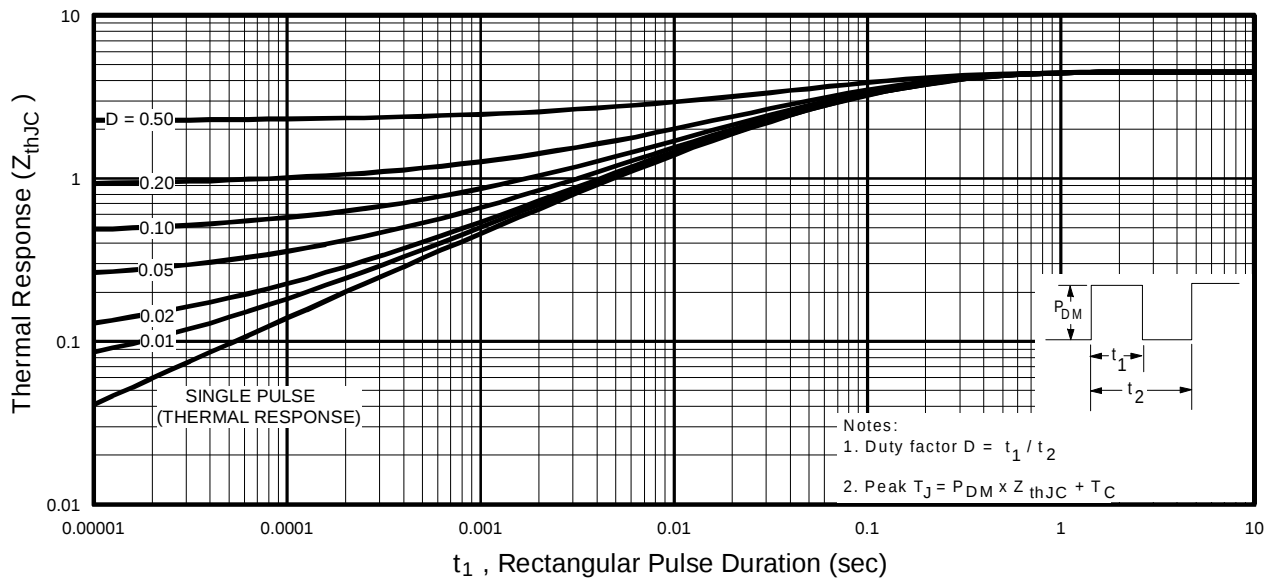
**Fig 9.** Maximum Drain Current Vs. Case Temperature



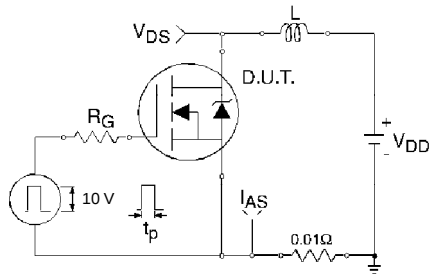
**Fig 10a.** Switching Time Test Circuit



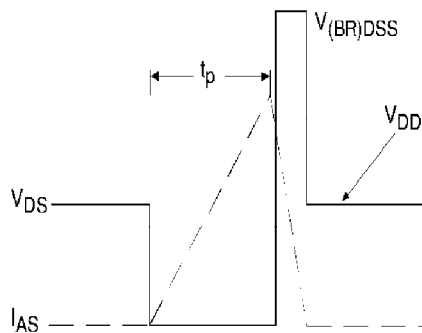
**Fig 10b.** Switching Time Waveforms



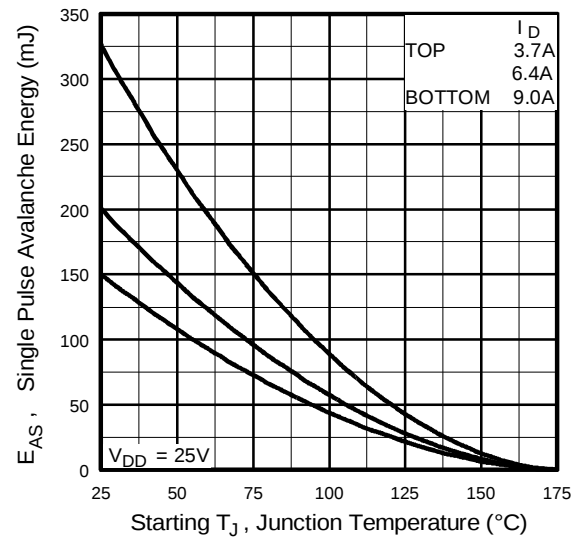
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



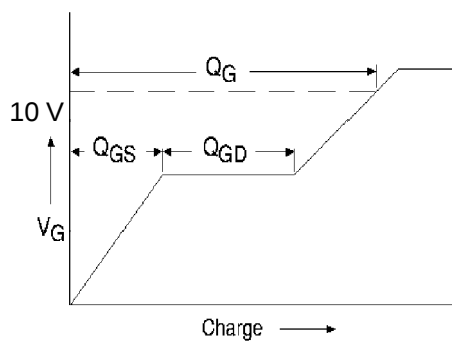
**Fig 12a.** Unclamped Inductive Test Circuit



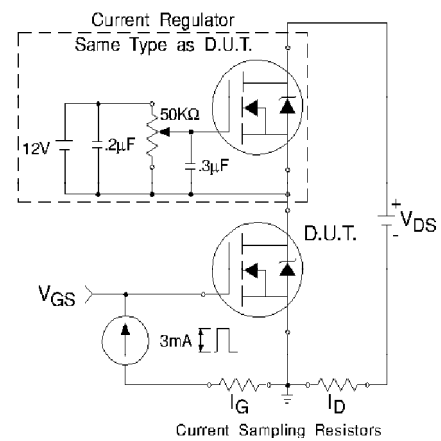
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

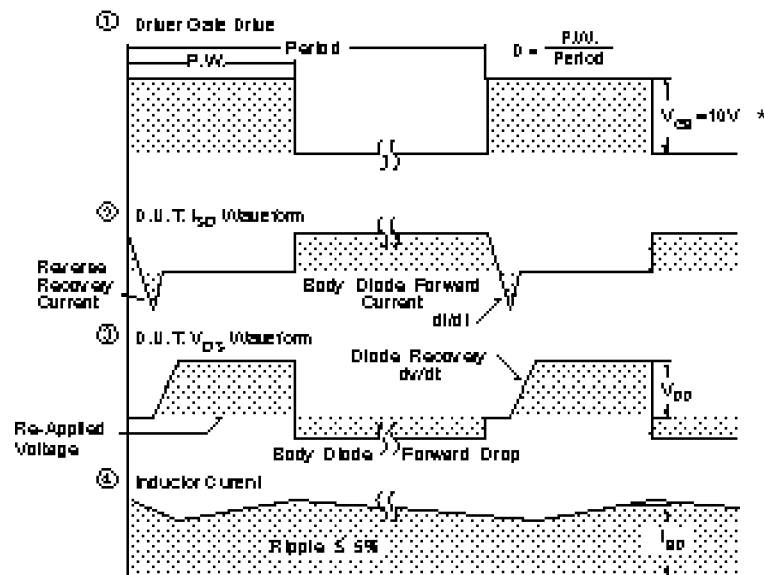
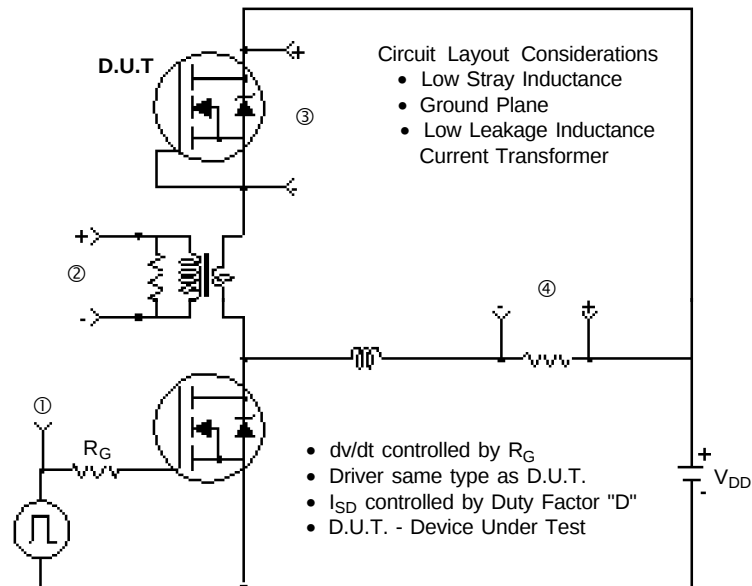


**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit

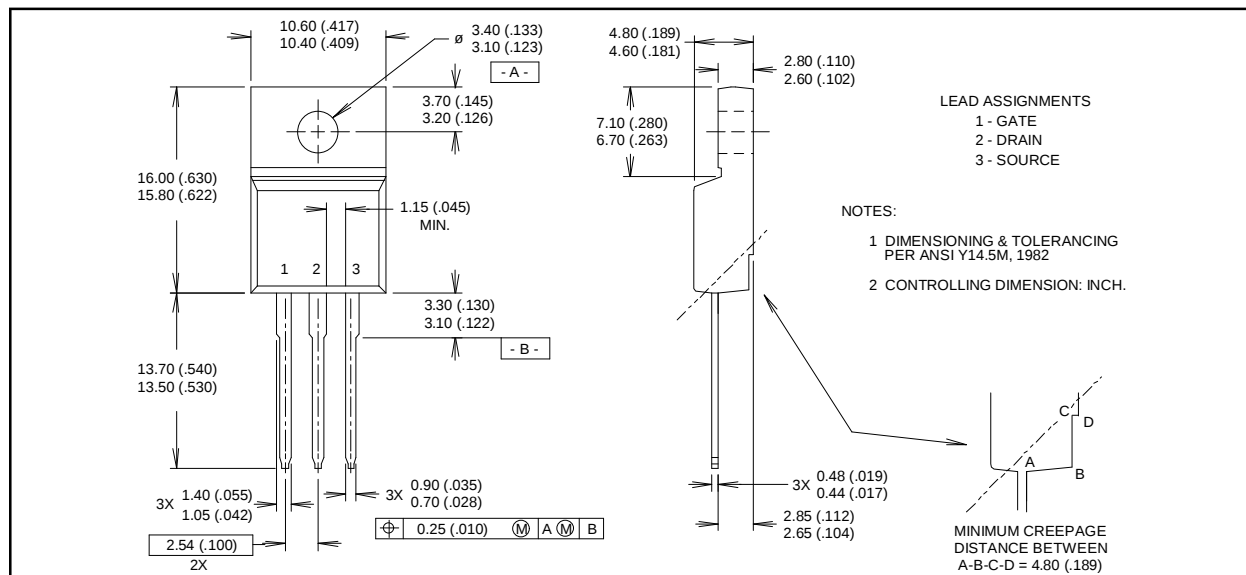


\*  $V_{GS} = 5V$  for Logic Level Devices

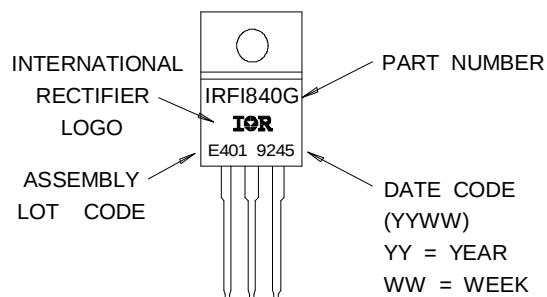
**Fig 14. For N-Channel HEXFETS**



Dimensions are shown in millimeters (inches)



EXAMPLE: THIS IS AN IRFI840G  
WITH ASSEMBLY  
LOT CODE E401



# International Rectifier

**WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331  
**EUROPEAN HEADQUARTERS:** Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020  
**IR CANADA:** 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 2Z8, Tel: (905) 475 1897  
**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590  
**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111  
**ST: K&H Bldg.,** 2F, 3-30-4 Nishi-Ikeburo 3-Chome, Toshima-Ki, Tokyo Japan 171 Tel: 81 3 3983 0086  
**UTHEAST ASIA:** 315 Outram Road, #10-02 Tan Boon Liat Building, Singapore 0316 Tel: 65 221 8371  
<http://www.irf.com/> *Data and specifications subject to change without notice.* 4/96